					Application/Control No.		Applicant(s)/Patent Under Reexamination SHINOHARA ET AL.			
	Notice of References Cited			Examin r		Art Unit	Dage 1 o	Page 1 of 1		
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U.S. PATENT DOCUMENTS DOCUMENT										
*		DOCUMENT NO.	DATE	NAME		CLASS	SUBCLASS	SOURCE *	OTHER	
	A	5,250,339	Oct. 1993	Tani et al.		428	65.5			
	В	6,071,607	Jun. 2000	Okuyama et al.		428	332			
	С	5,863,609	Jan. 1999	Yamamoto		427	283			
	D	5,879,783	Mar. 1999	Chang et al.		428	141			
	E	5,871,621	Feb. 1999	Ross		204	192.2			
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	G									
]	Н									
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屵	FOREIGN PATENT DOCUMENTS							DOCUME	NT	
*		DOCUMENT NO.	DATE	COUNTR	COUNTRY NAME CLASS			SOURCE ** APS OTHER		
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	s									
	Т					<u> </u>				
	NON-PATENT DOCUMENTS								DOCUMENT SOURCE **	
*		DOCUMENT (Including Author, Title Date, Source, and Pertinent Pages)						APS	OTHER	
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^{*}A copy of this reference is not being furnished with this Office action. (See Manual of Patent Examining Procedure, Section 707.05(a).)
**APS encompasses any electronic search i.e. text, image, and Commercial Databases.
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Notice of References Cited